

## NOTICE OF REFERENCES CITED

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APPLICANT(S)

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*Forbes et al*

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*	DOCUMENT NO.	DATE	NAME	CLASS	SUB-CLASS	FILING DATE IF APPROPRIATE
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*	DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUB-CLASS	PERTINENT SHTS. PP. DWG. SPEC.
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Viet Q. Nguyen  
Primary Examiner

EXAMINER	DATE
V. Nguyen	2/16/99

\* A copy of this reference is not being furnished with this office action.  
(See Manual of Patent Examining Procedure, section 707.05 (a).)